Background characterization for the GERDA experiment

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Outline:

Motivation

- GERDA Phase-I data and analysis:
 - modeling of the background components
 - decomposition of the background spectrum
- Conclusion

Motivation

GERDA experiment is searching for the neutrinoless double beta ($0\nu\beta\beta$) decay of ⁷⁶Ge, using an array of HPGe detectors enriched in ⁷⁶Ge isotope.

 $\begin{array}{ll} \mbox{limit: } T^{0\nu}_{1/2}(^{76}\mbox{Ge}) > 1.9 \times 10^{25} \mbox{ y (90\% C.L.) from HdM Collaboration} & [Eur. Phys. J. A 12, 147154 (2001)] \\ \mbox{claim: } T^{0\nu}_{1/2}(^{76}\mbox{Ge}) = 1.2 \times 10^{25} \mbox{ y [Phys. Lett. B 586 (2004) 198-212]} \end{array}$

GERDA Phase-I: $T_{1/2} > 2 \times 10^{25}$ y \rightarrow test the claim **GERDA Phase-II:** $T_{1/2} > 10^{26}$ y

To achieve a higher sensitivity on the $T_{1/2}$

- \rightarrow larger exposure
- \rightarrow lower background rate around Q_{BB}
 - Background characterization& suppression



Considered data set:

- 9 November 2011 5 January 2013
- \rightarrow total live DAQ time: 340.94 days
- \rightarrow total mass of the coaxial type ^{enr}Ge detectors: 14.63 kg

total exposure: 13.65 kg x yr



GERDA Phase I data: background spectrum





 $T_{1/2} = 1600 \text{ y}$

 $T_{1/2} = 3.8 d$

 $T_{1/2} = 183 s$)

 $T_{1/2} = 164 \ \mu s$)

 $T_{1/2} = 138.4 \text{ d}$



 0.09 ± 0.02

 $(5.3\,{
m MeV}\,{<}\,{
m E}\,{<}\,7.5\,{
m MeV})$

const





Given a strong prior probability on the half life parameter

0.86

() Py OG 10² 10

MC simulations to model the energy spectrum:

- 1) ²¹⁰Po on thinDL surface
- 2) ²²⁶Ra & daughters on thinDL surface
- 3) ²²²Rn & daughters in LAr close to thinDL surface



 ²²²Rn & daughters in LAr due to
 ²²⁶Ra contamination on thinDL surface and on other materials close to detectors, e.g, holders of the detectors.

 226 Ra (E_a = 4.8 MeV, $T_{1/2} = 1600 \text{ y}$ 222 Rn (E_a = 5.5 MeV, $T_{1/2} = 3.8 d$ ²¹⁸Po (E_{α} = 6.0 MeV, $T_{1/2} = 183 s$) ²¹⁴Pb (T_{1/2} = 0.45 h) ²¹⁴Bi (T_{1/2} = 0.33 h) ²¹⁴Po (E_{α} = 7.7 MeV, $T_{1/2} = 164 \ \mu s$) ²¹⁰Pb ($T_{1/2}$ = 22.3 y) ²¹⁰Bi (T_{1/2} = 5.01 d) ²¹⁰Po (E_{α} = 5.3 MeV, $T_{1/2} = 138.4 \text{ d}$ ²⁰⁶Pb (stable)

Simulated energy spectrum of different model components



²²²Rn & daughters in LAr close to thinDL surface

Binned maximum posterior fit to the sum ^{enr}Ge-coax spectrum in (3500 – 7500) keV window

Maximized the posterior probability using Markov Chain Monte Carlo in Bayesian Analysis Toolkit BAT:

[A. Caldwell et. al., Comput. Phys. Commun. 180, 2197 (2009)]

Posterior probabilit

Ey:
$$P(\vec{\lambda}|\vec{n}) \propto P(\vec{n}|\vec{\lambda})P_0(\vec{\lambda})$$

Likelihood:

$$P(\vec{n}|\vec{\lambda}) = \prod_{i} P(n_i|\lambda_i) = \prod_{i} \frac{e^{-\lambda_i}\lambda_i^{n_i}}{n_i!}$$

 n_i number of observed, λ_i number of expected events in i-th bin

 $\lambda_i = \sum \lambda_{i,M}$ \rightarrow sum contribution of each model component M

$$\lambda_{i,M} = N_M \int_{\Delta E_i} f_M(E) dE$$

scaling parameter for the component M

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Experimental energy spectrum of sum ^{enr}Ge-coax detectors together with the best fit model:



Colored probability intervals: [R. Aggarwal and A. Caldwell, Eur. Phys. J. Plus 127 24 (2012)]

- fit window: (3500 7500) keV
- p-value of the fit: 0.7
- 80 bins of width 50 keV:
 79% in the green band
 98% in the yellow band

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Extrapolation of the alpha-induced event model to ROI (160 keV): (1939 – 2019) plus (2059 – 2139) keV



Experimental energy spectrum of sum ^{enr}Ge-coax detectors together with the best fit model:



GERDA Phase I data: decomposition of the bg spectrum

Binned maximum posterior fit to the sum ^{enr}Ge-coax spectrum in (570 – 7500) keV window

- ${\scriptstyle \bullet}$ fit window enlarged to include $Q_{\beta\beta}$
- background components considered in the global fit:
 - \rightarrow K-42, K-40, Bi-214, Ac-228 & Th228 (beta- / gamma-induced events) and alpha-induced event model
- p-value of the fit: 0.3

Experimental energy spectrum of sum ^{enr}Ge-coax detectors together with the best fit model:



Conclusion

- GERDA Phase I data-taking is ongoing.
- Blind analysis: 40 keV window around $Q_{\beta\beta} = 2039$ keV is blinded.
- Model the background energy spectrum before unblinding: Promising "preliminary" results !
- Background model is important:
 - understand the background in Phase I & mitigate it further in Phase II
 - estimate the expected number of background events & the shape of the background spectrum around Q_{BB} for the upcoming $0\nu\beta\beta$ analysis.

Backup









Analysis of event rate distributions:

- Fit the distribution with an exponential function
- Maximized quantity posterior probability:

 $P(\vec{\lambda}|\vec{n}) \propto P(\vec{n}|\vec{\lambda})P_0(\vec{\lambda})$

- Set a prior on the half life parameter: $P_0(T_{1/2}) = Gaus(138.4 \text{ days}, 0.2 \text{ days})$ half-life of ²¹⁰Po

- Likelihood:

$$P(\vec{n}|\vec{\lambda}) = \prod_{i} P(n_i|\lambda_i) = \prod_{i} \frac{e^{-\lambda_i}\lambda_i^{n_i}}{n_i!}$$

n_i: raw number of counts in i-th bin

(not scaled, not corrected for live time fraction,

 $\boldsymbol{\lambda}_i$: expectation in the i-th bin

corrected with the live time fraction in that bin

$$\lambda_i = \epsilon_i \int_{(i-1)\Delta t}^{i\Delta t} N_0 \cdot e^{-\ln 2t/T_{1/2}} dt$$

$$N(t) = N_0 \cdot e^{-ln2t/T_{1/2}}$$



Event rate distribution of events with 3500 keV< E < 5300 keV in sum ^{enr}Ge-coax Model: exponentially decaying event rate



Event rate distribution of events with 3500 keV< E < 5300 keV in sum ^{enr}Ge-coax Model: exponential + constant rate





Event rate distribution of events with E > 5300 keV in sum ^{enr}Ge-coax Model: constant rate

